


<b>Search Notes</b>  	<b>Application/Control No.</b>  10751475	<b>Applicant(s)/Patent Under Reexamination</b>  INOUE, HARUO
	<b>Examiner</b>  Kim, Andrew	<b>Art Unit</b>  3714

SEARCHED			
Class	Subclass	Date	Examiner
463	16-21, 30-33	10/10/2008	AK
273	143R, 138.1	10/10/2008	AK

SEARCH NOTES		
Search Notes	Date	Examiner

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner

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